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PROJECT OVERVIEW: Innovative and validated submicron
to meso-scale modeling of the evolution of interface structure
and properties under extreme strains

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Mara, J. Mayeur, R. McCabe, H. Mourad, S. Sintay, S. Vogel,
J. Wang, S. Zheng

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November 14-16, 2011



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Abstract

Irene Beyerlein

The goal of this work is to determine the class of bi-metal interfaces that will create composite materials with extraordinary failure resistance under extreme mechanical strains. The evolution of bi-metal interface properties were studied in Cu-Nb multi-layered composites synthesized using a severe plastic deformation (SPD) technique called accumulative roll bonding (ARB). EBSD and TEM analyses strongly suggest that most interfaces in nanolayered ARB material are $\{112\}_{\text{fcc}}//\{112\}_{\text{bcc}}$ with a Kurdjumov-Sachs orientation relationship. Atomistic simulation, dislocation theory, and polycrystal plasticity modeling are employed to determine the structural aspects that make this interface stable under SPD and its role in governing slip and twinning activity.

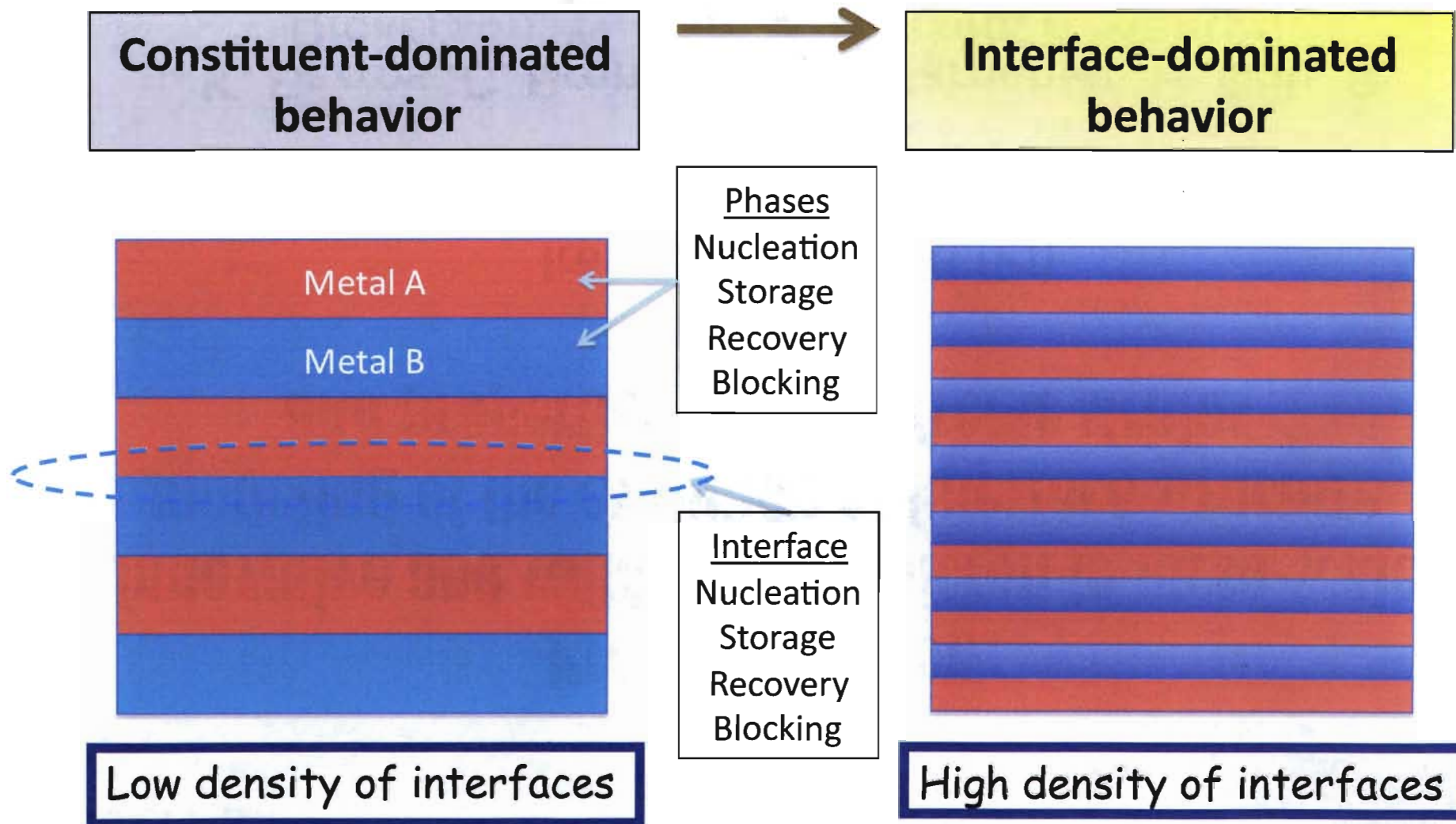
Project Overview:
**Innovative and validated submicron to meso-scale
modeling of the evolution of interface structure
and properties under extreme strains**

Irene J. Beyerlein (PI)

DR TEAM

**K. Barros, C. Bronkhorst, J. Carpenter, H. Chu, R.
Dickerson, W. Han, B. Hansen, K. Kang, T.
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Interface-driven material behavior



Hypothesis and Goal

1-2 microns

Bulk Dislocation density 1 micron to 500 nm

Substructure

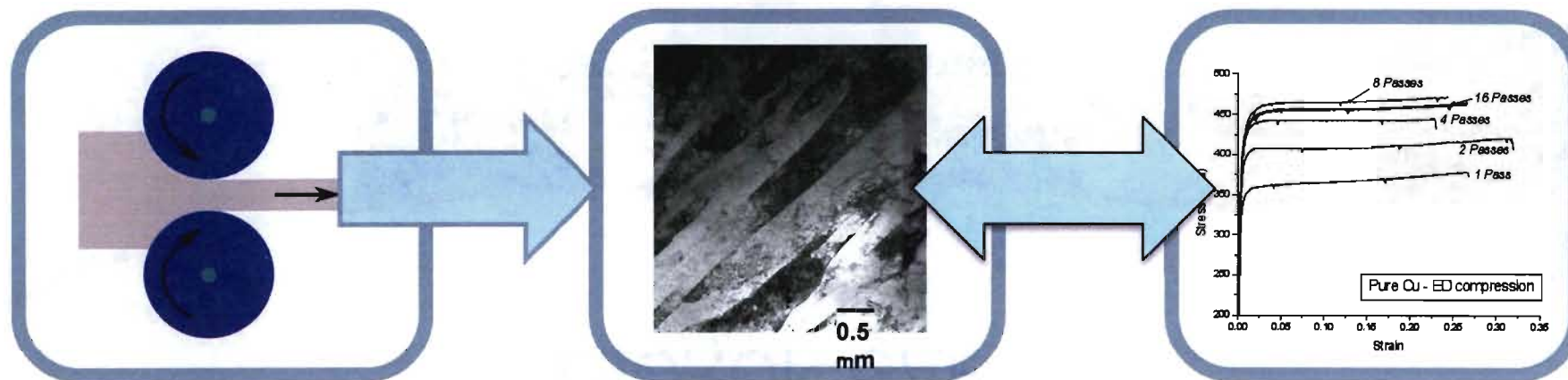
500 nm to 50 nm

MICRON GAP

Interface Dominance

To pioneer an innovative Meso (nm to micron) Multi-
Scale (M²S) model for synthesizing interface-dominant
materials with the interfacial properties we want

Process Aware Performance



**Fabrication
Process**

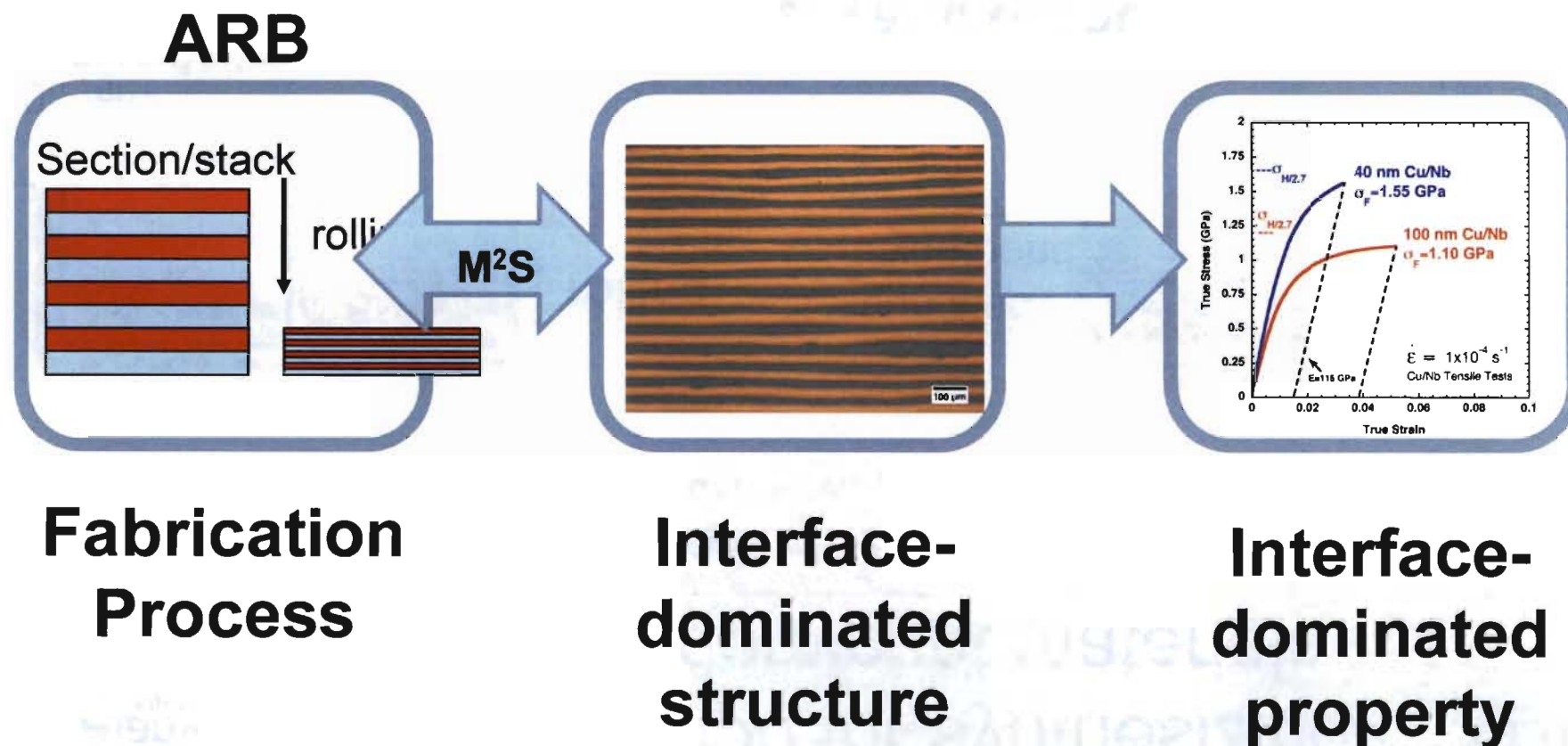
Microstructure

Property

Performance



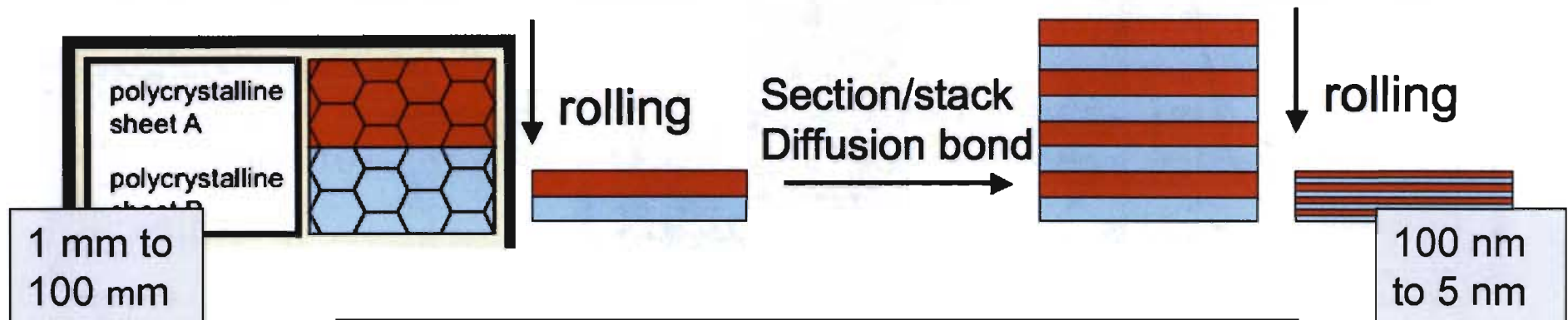
Process Aware Performance for interface-dominated materials



Model method for synthesizing interface dominant materials

Accumulative Roll Bonding (ARB):

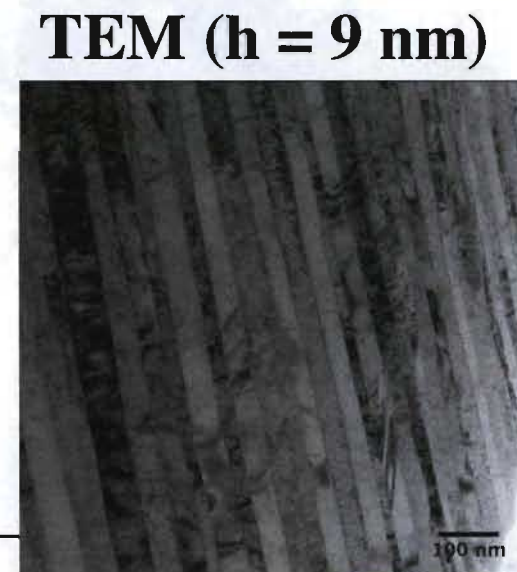
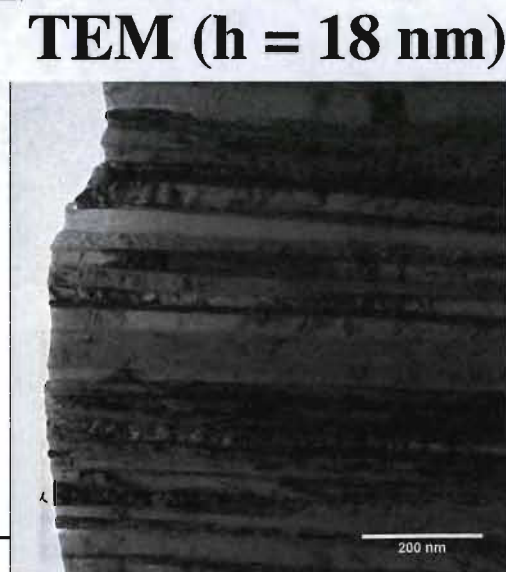
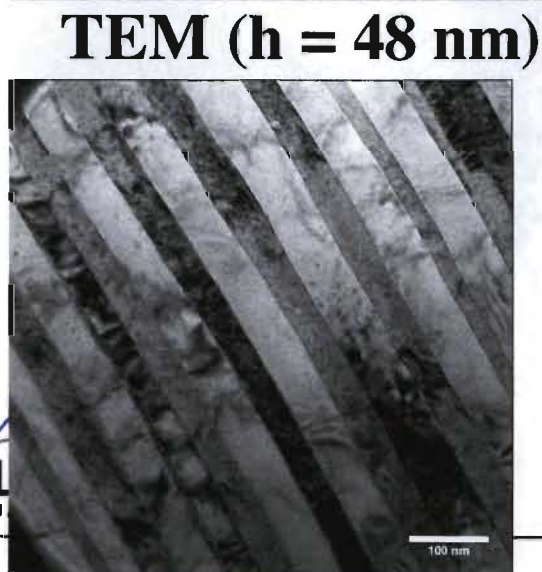
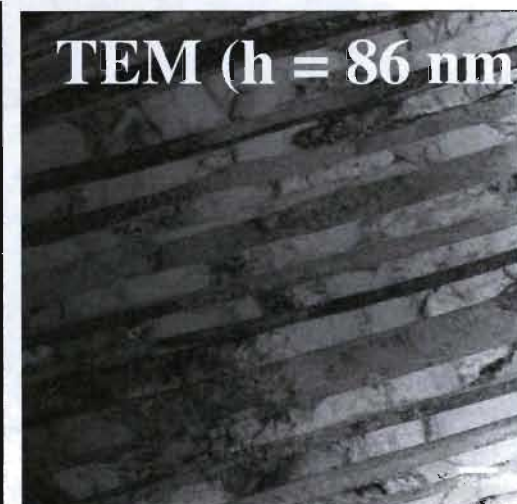
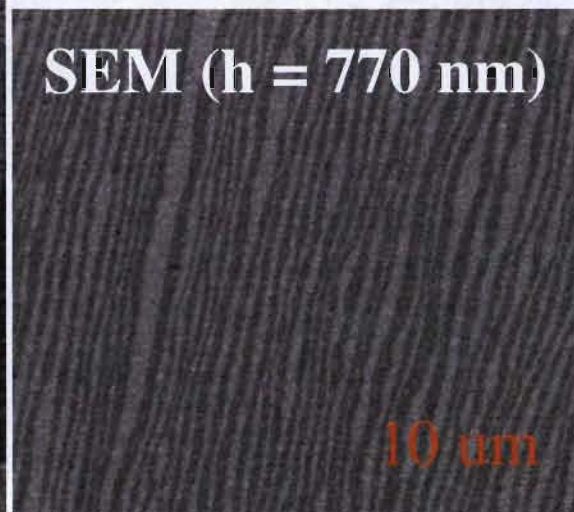
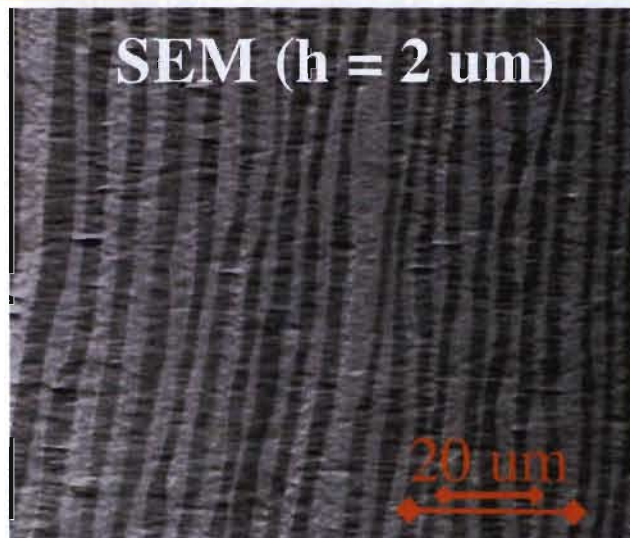
Achieving extreme strains beyond those possible with conventional rolling



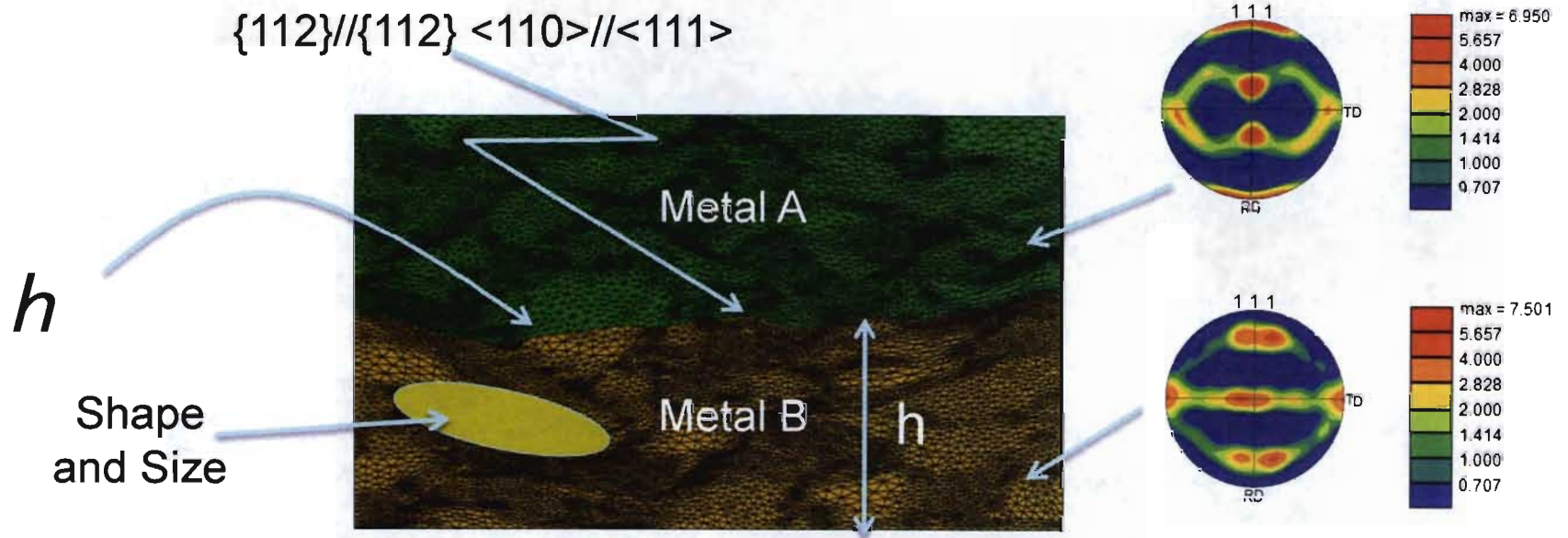
ARB serves several purposes:

- *Synthesis of bulk layered material*
 - *Controllable strain*
 - *Controllable layer thickness*
 - *Model architecture*
- *One primary interface plane*
- *Relevant thermomechanical process*

Cu/Nb ARB synthesis across length scales



Deliverables



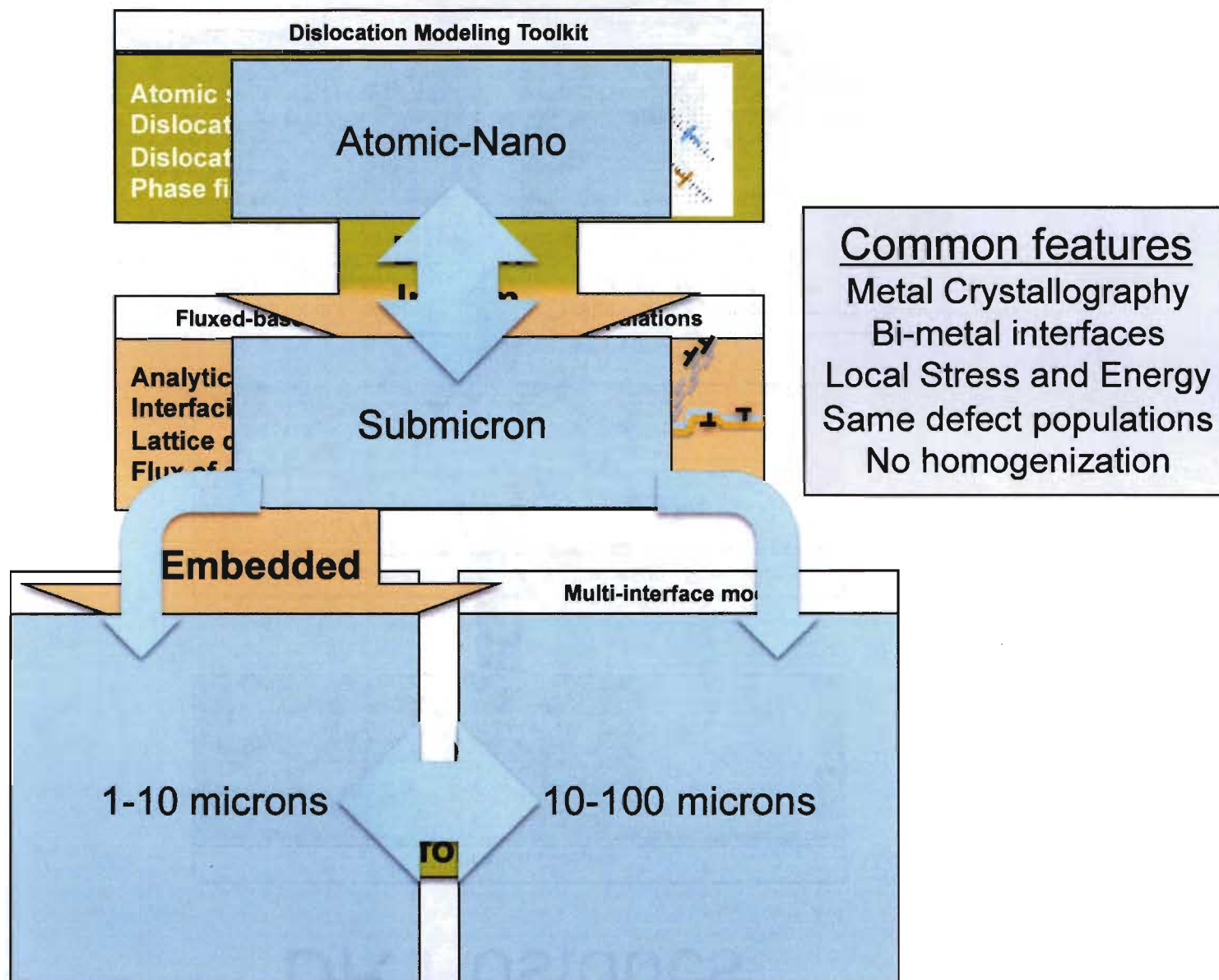
OUTPUT

- Texture evolution,
- Lattice dislocation density evolution
- Interfacial dislocation density evolution
- Interface crystallography
- Layer thickness
- Grain shape
- Internal stresses and strains

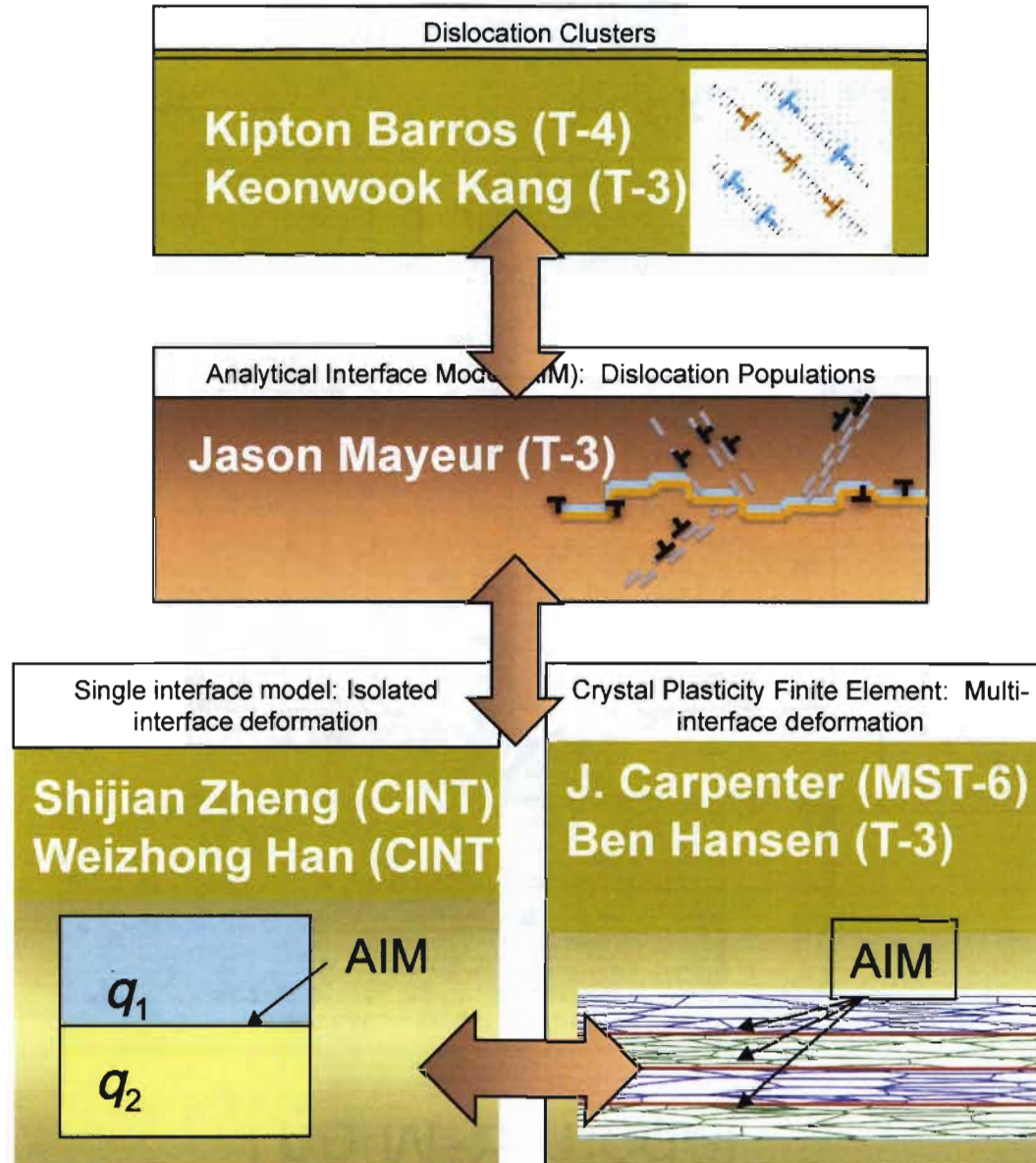
VALIDATION

- Texture evolution,
- Dislocation density in phases
- Defects in interface
- Interface crystallography
- Layer thickness
- Hardness
- Directional flow stress vs strain curves

The M²S model

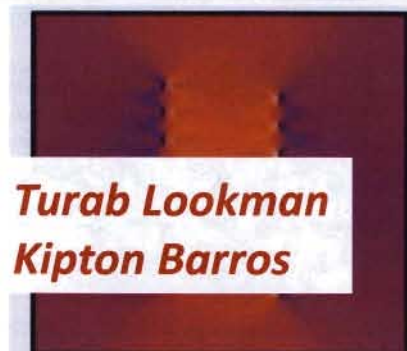


DR Postdocs



DR team personnel

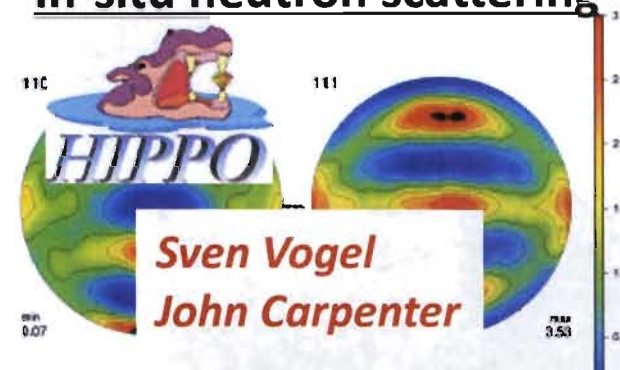
Phase field modeling



Nanomechanical Testing



In-situ neutron scattering



TEM

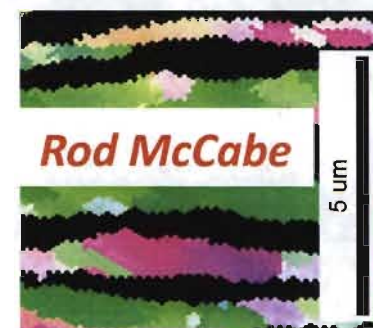
HR-TEM

In-situ TEM

Synthesis



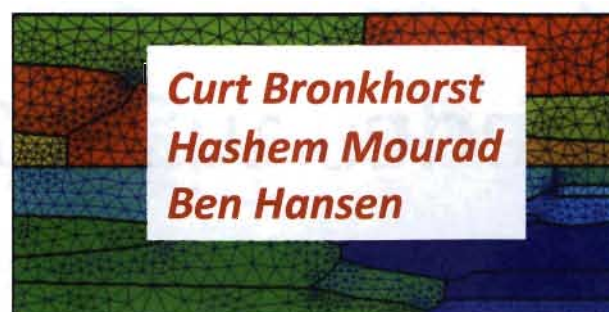
EBSD



Dislocation Dynamics & Theory

*Irene Beyerlein
Jian Wang
Jason Mayeur*

Crystal Plasticity Finite Element



Microstructure Builder

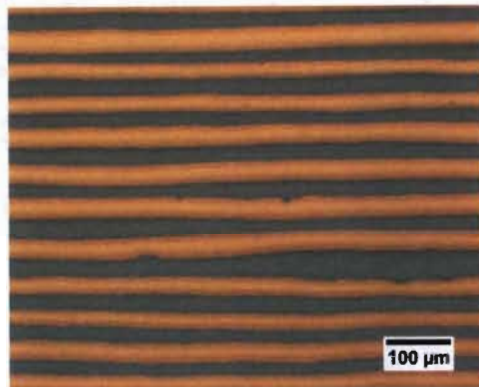


Highlight capabilities

Bulk synthesis of two-phase interface dominant composites

Mara, LeDonne, Nizolek, Carpenter

Featured: Mara's talk

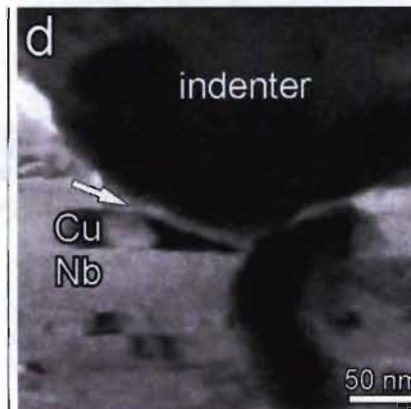


In-situ nano-indentation of two-phase metals

Shijian Zheng

R. Dickerson

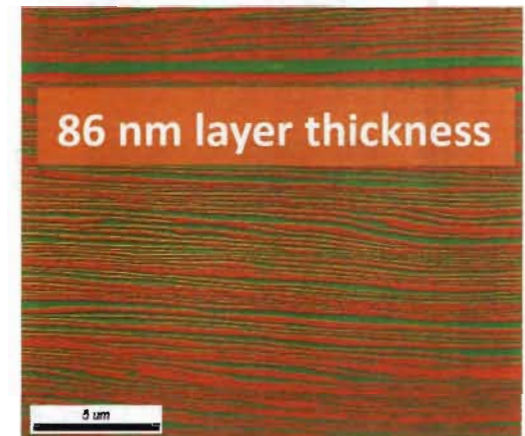
Featured: Zheng's poster



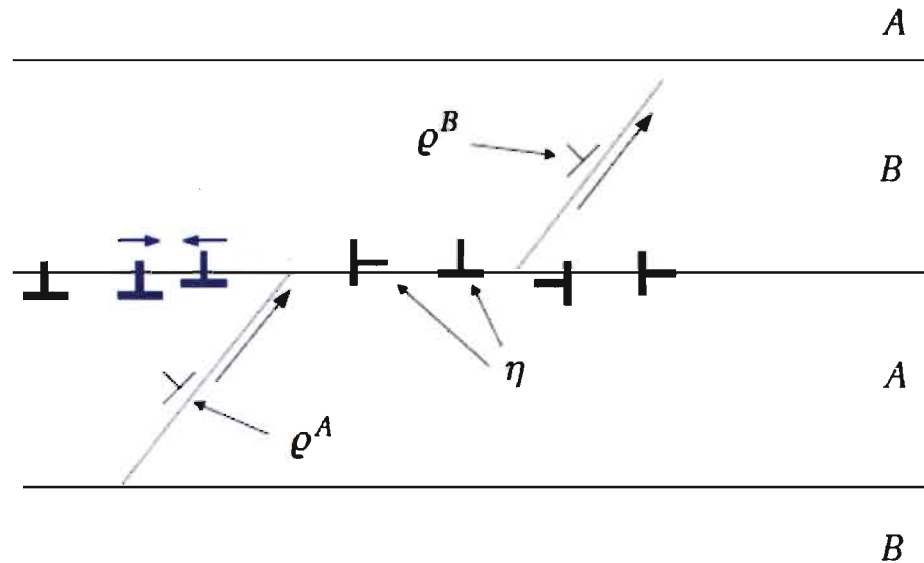
EBSD at fine length scales

Rod McCabe

Featured: McCabe's poster



Analytical interface model: providing interface physics to the meso-scale



Rate equations for dislocation density evolution for a bi-metal composite

- Nucleation
- Annihilation
- Transmission
- Reflection
- Absorption

Analytical interface model: a fluxed-based approach

$$\dot{\rho} = \sum \Phi_r - \frac{1}{V} \oint_{\partial V} \mathbf{f} \cdot \mathbf{a} \, dA$$

Roters et al. 2010

Flux based expression for
the evolution of
dislocation densities

Formulation
for two-phase
composite

$$\frac{1}{V} \int_{\partial V} \mathbf{f} \cdot \mathbf{a} \, dA \approx \frac{1}{V} \sum_n \left(j_{\text{tran}}^{(n)} + j_{\text{abs}}^{(n)} \right) A^{(n)}$$

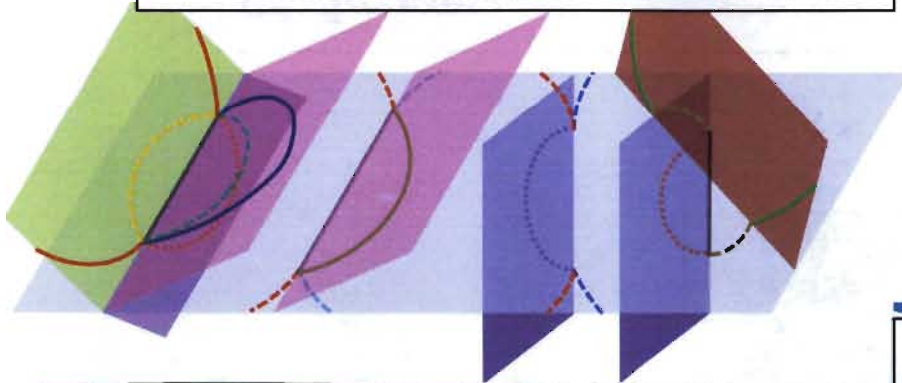
AIM: connection
with interface
physics

$$j_{\text{tran}} = \sum_{\alpha} \sum_{\beta} \chi^{(\alpha, \beta)} \tilde{\mathbf{f}}^{(\alpha)} \cdot \mathbf{a}$$

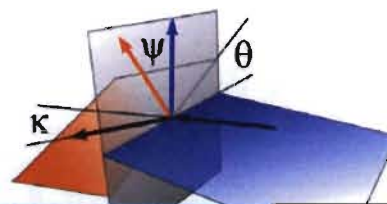
$$\chi^{(\alpha, \beta)} = m'' h(\tau, \eta)$$

Analytical interface model: informed by lower-length scale physics

Dislocation dynamics: transmission



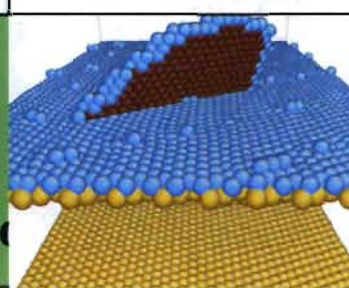
Crystal plasticity:
transmission; residuals



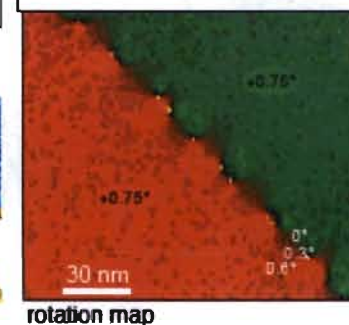
Phase field:
Annihilation



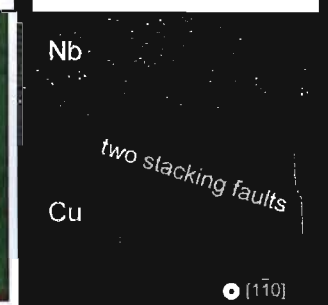
MD: Nucleation



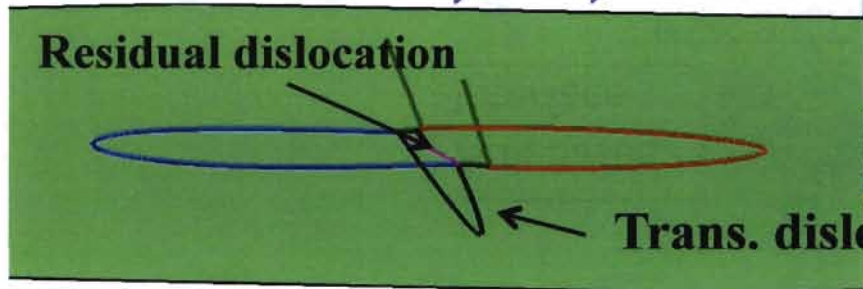
Rotation Map



Emission



Residual dislocation



Trans. disl

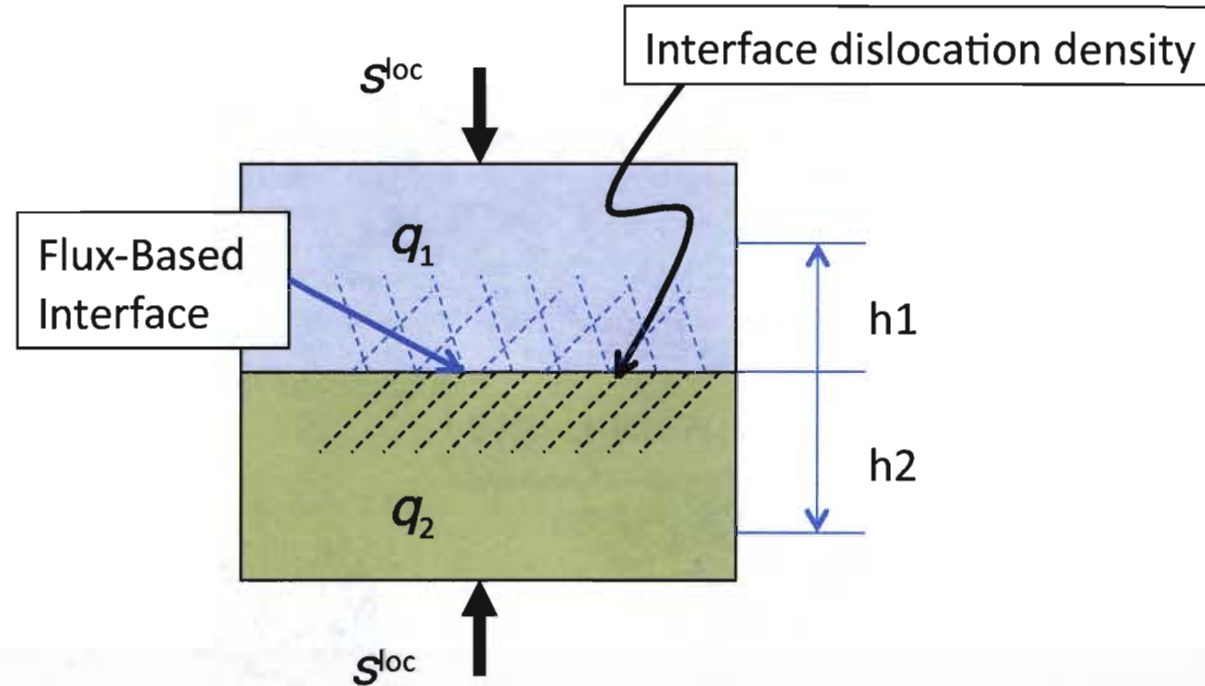
Residual dislocations left from
transmissions across interface

Interface dislocations annihilated within the interface

$$\dot{\eta}^E = \underbrace{j_{\text{tran}}}_{\text{Residual}} - \phi_{\text{rxn}}^{EA} - \phi_{\text{ann}}^E$$

Emission from the interface

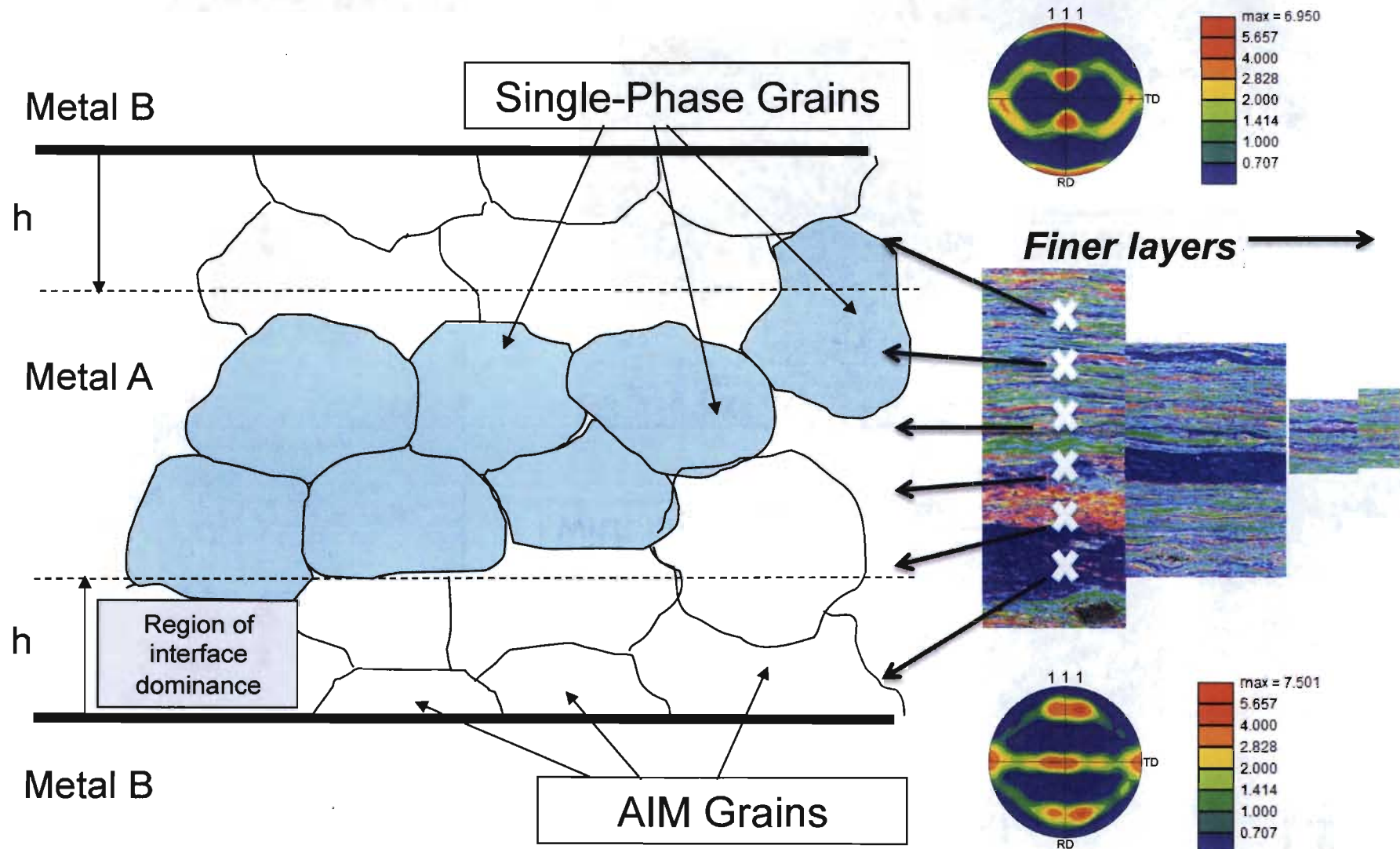
Single Interface Model



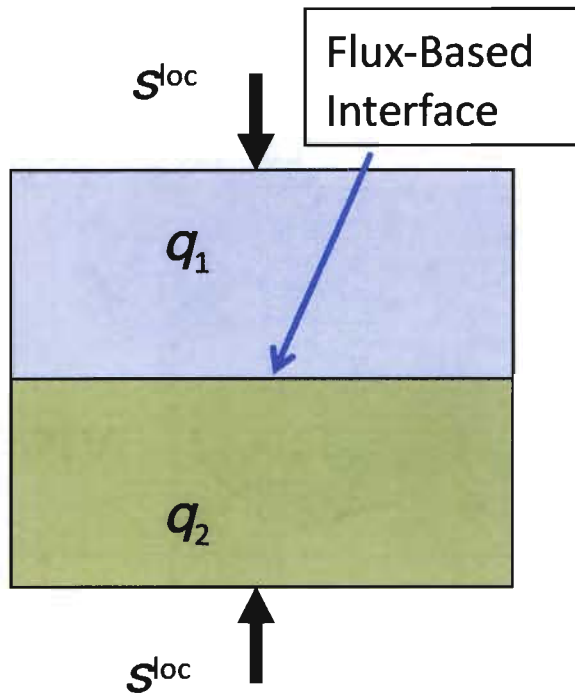
Predictions:

- How flux-controlling interfaces affect slip activity and reorientation
- Interface affected region (internal stress, dislocation density)
- Interfacial density

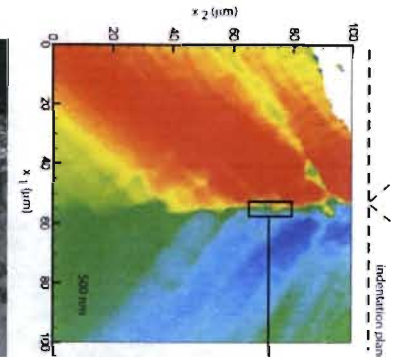
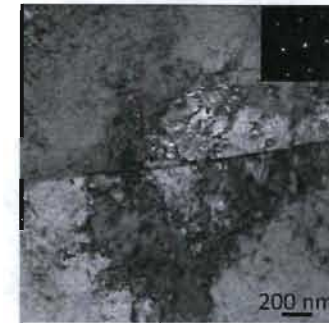
Interface-affected grains in the multiple interface model



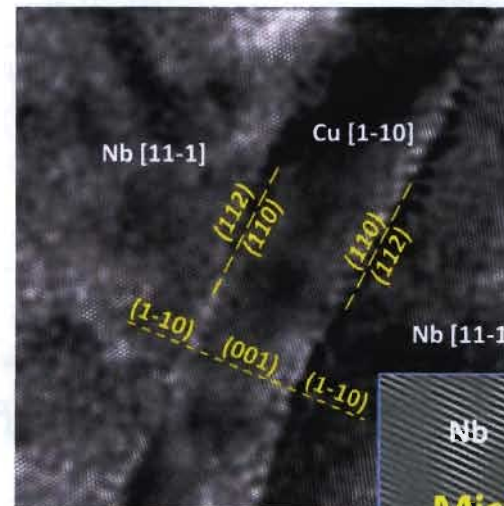
Single Interface Model



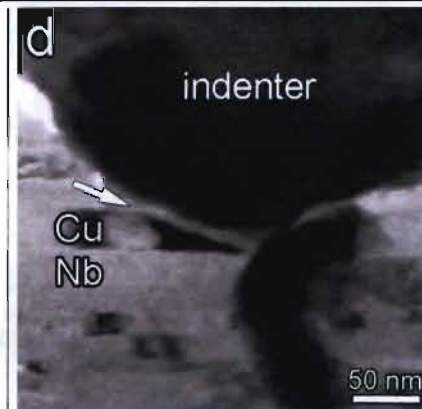
Bulk dislocation density, rotations, & strain gradients with layer h



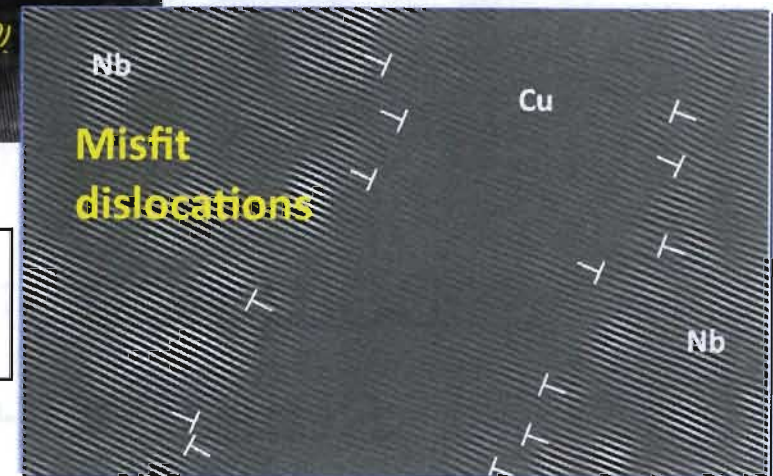
Interface crystallography as a function of strain and layer h



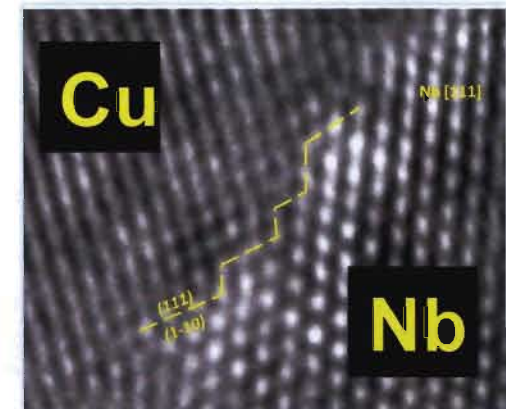
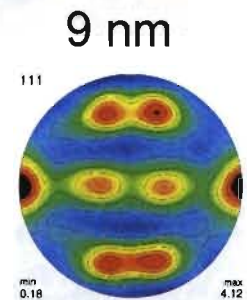
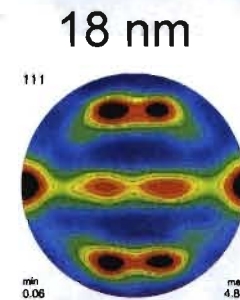
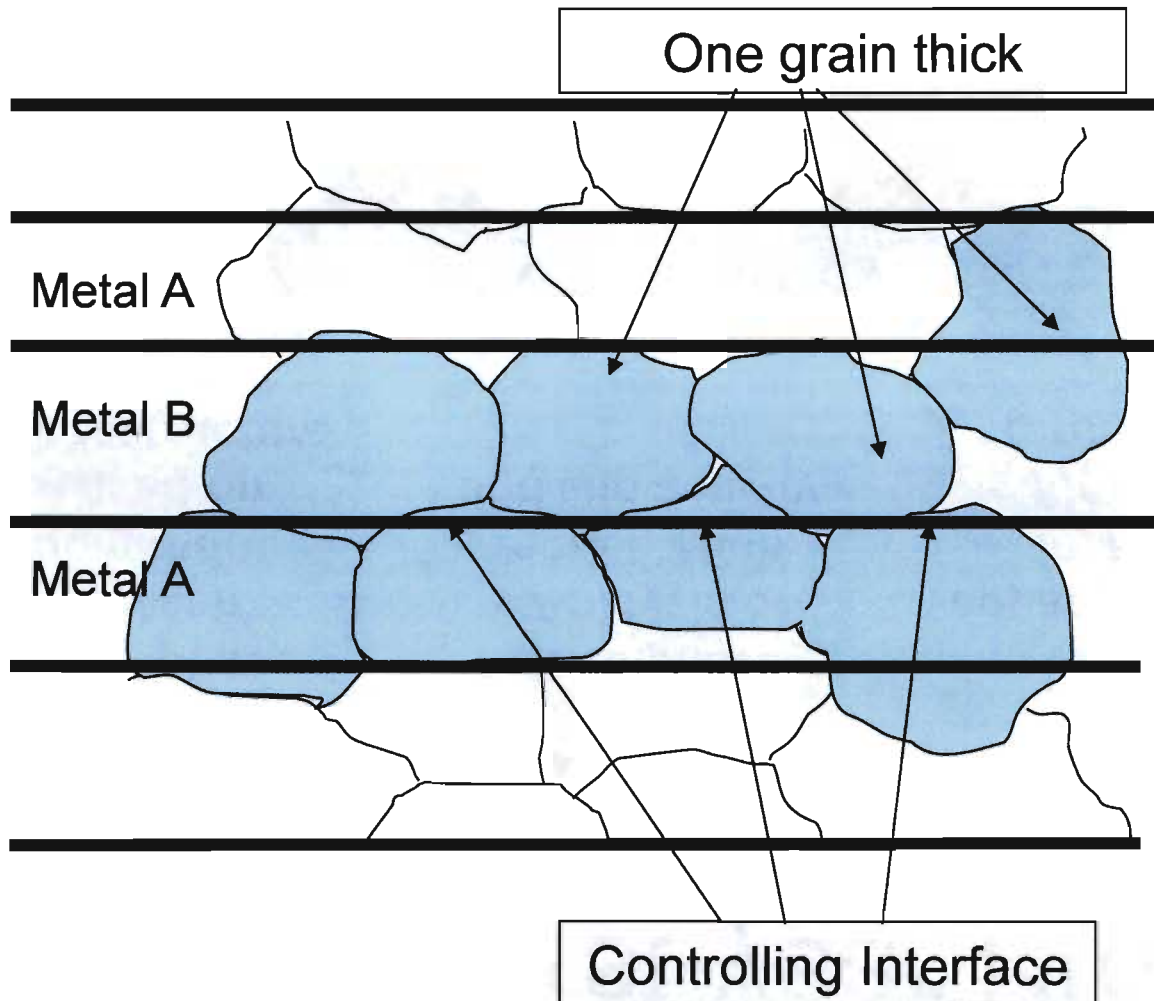
Kinetics: In-situ TEM



Defect density in the interface



Multiple interface model: Evolution to finer layers



First-year Progress

Multi-interface Models

- Two phase
 - Mesh generation based on microstructure

Single-interface Models

- Two phase
 - Analysis of reorientation and slip activity

Interface Flux Models

- Rate equations for an interface
 - Flux based formulation

Dislocation Models

- Interface formulation
 - Interface physics



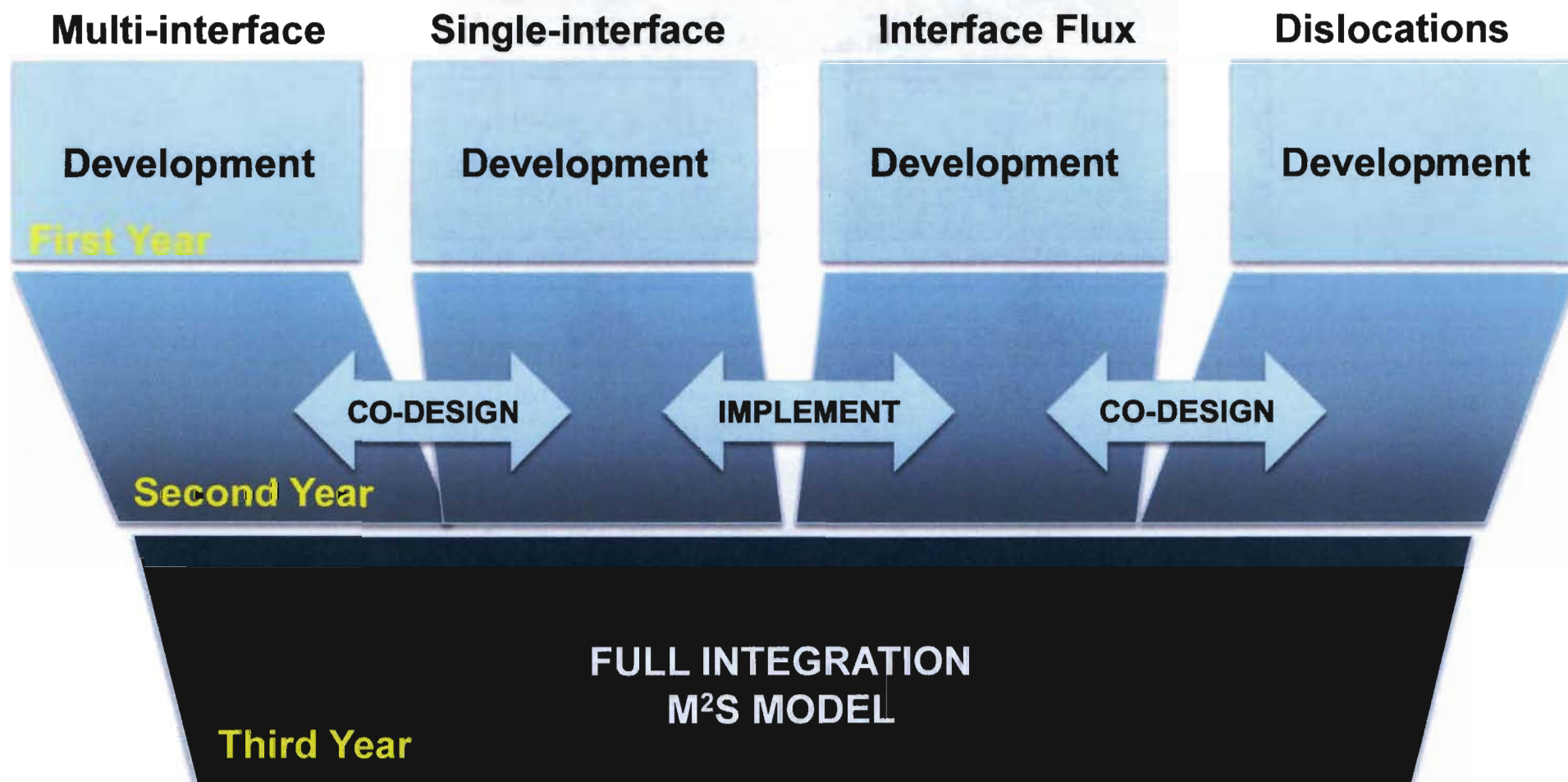
- CPFE framework
- Boundary conditions
- Single crystal model for bulk

- Programming for direct implementation

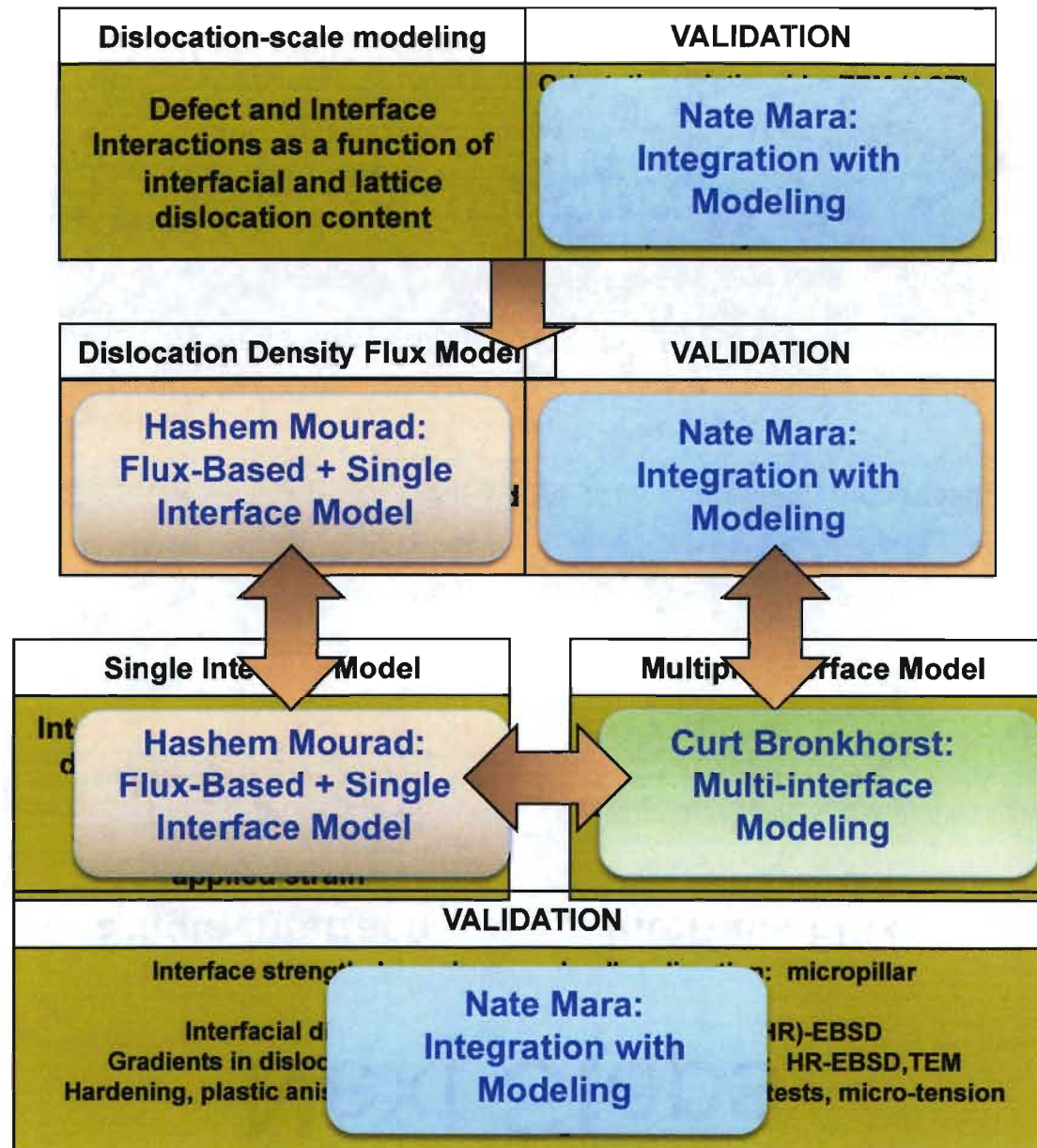
- Identifying key processes
 - quantifying coefficients

Integration with experiment

Next Steps



Upcoming Talks



Upcoming Posters

